Product data sheet

1. General description

Planar passivated Silicon Controlled Rectifier (SCR) in a TO220 package intended for use in applications requiring good bidirectional blocking voltage and high surge current capability and high junction temperature capability ($T_{i(max)} = 150$ °C).

2. Features and benefits

- High junction operating temperature capability (T_{i(max)} = 150 °C)
- · High bidirectional blocking voltage capability
- · Very high current surge capability
- · High thermal cycling performance
- · Planar passivated for voltage ruggedness and reliability

3. Applications

- Capacitive Discharge Ignition (CDI)
- · Crowbar protection
- Inrush protection
- Motor control
- Voltage regulation

4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---------------------|--|--|-----|-----|-----|------|
| V_{DRM} | repetitive peak off-state voltage | | - | - | 600 | V |
| I _{T(RMS)} | RMS on-state current | half sine wave; $T_{mb} \le 134$ °C; Fig. 1; Fig. 2; Fig. 3 | - | - | 16 | А |
| I _{TSM} | non-repetitive peak on- state current | half sine wave; $T_{j(init)} = 25 \text{ °C}$; $t_p = 10 \text{ ms}$; Fig. 4; Fig. 5 | - | - | 188 | А |
| | | half sine wave; $T_{j(init)}$ = 25 °C; t_p = 8.3 ms | - | - | 207 | Α |
| T _j | junction temperature | | - | - | 150 | °C |
| Static ch | aracteristics | | | | | |
| I _{GT} | gate trigger current | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C}; Fig. 7$ | 5 | - | 10 | mA |
| I _H | holding current | V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u> | - | - | 40 | mA |
| V _T | on-state voltage | I _T = 16 A; T _j = 25 °C; <u>Fig. 10</u> | - | - | 1.6 | V |
| Dynamic | characteristics | | | | | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 402 V; T_j = 150 °C; (V_{DM} = 67% of V_{DRM}); exponential waveform; gate open circuit | 400 | - | - | V/µs |

SCR

5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-----------------------------------|--------------------|----------------|
| 1 | K | cathode | mb | . 51 |
| 2 | А | anode | | A K G |
| 3 | G | gate | | sym037 |
| mb | A | mounting base; connected to anode | | |

6. Ordering information

Table 3. Ordering information

| Type number | Package Name | Orderable part number | Packing method | Small packing quantity | Package version | Package issue date |
|--------------|-----------------|-----------------------|----------------|------------------------|-----------------|--------------------|
| TYN16-600CTF | TO220 | TYN16-600CTFQ | Tube | 50 | SOT78 | 13-Jun-2008 |

7. Marking

Table 4. Marking codes

| Type number | Marking codes |
|--------------|---------------|
| TYN16-600CTF | TYN16 |
| | 600CTF |

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|---------------------|--|---|-----|------|------------------|
| V_{DRM} | repetitive peak off-state voltage | | - | 600 | V |
| V_{RRM} | repetitive peak reverse voltage | | - | 600 | V |
| I _{T(AV)} | average on-state current | half sine wave; T _{mb} ≤ 134 °C; | - | 10.2 | Α |
| $I_{T(RMS)}$ | RMS on-state current | half sine wave; $T_{mb} \le 134 ^{\circ}\text{C}$; Fig. 1; Fig. 2; Fig. 3 | - | 16 | А |
| I _{TSM} | non-repetitive peak on- state current | half sine wave; $T_{j(init)}$ = 25 °C; t_p = 10 ms; Fig. 4; Fig. 5 | - | 188 | А |
| | | half sine wave; $T_{j(init)}$ = 25 °C; t_p = 8.3 ms | - | 207 | Α |
| l ² t | I ² t for fusing | t _p = 10 ms; sine-wave pulse | - | 177 | A ² s |
| dl _⊤ /dt | rate of rise of on-state current | I _G = 20 mA | - | 100 | A/µs |
| I _{GM} | peak gate current | | - | 4 | Α |
| V_{GM} | peak gate voltage | | - | 5 | V |
| P_{GM} | peak gate power | | - | 10 | W |
| P _{G(AV)} | average gate power | over any 20 ms period | - | 1 | W |
| T _{stg} | storage temperature | | -40 | 150 | °C |
| T _j | junction temperature | | - | 150 | °C |

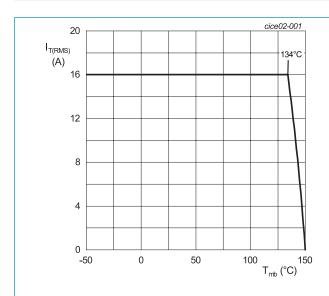
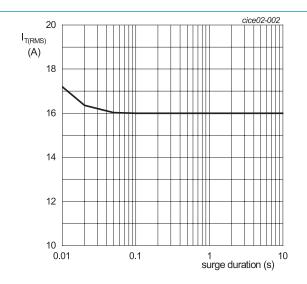
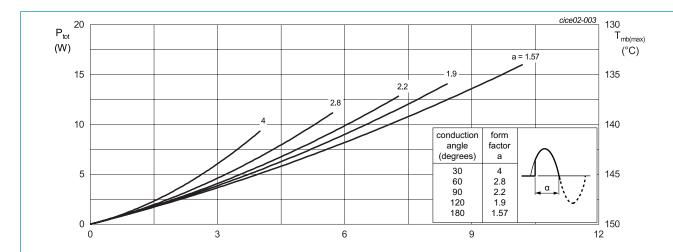


Fig. 1. RMS on-state current as a function of mounting base temperature; maximum values



f = 50 Hz; T_{mb} = 134 °C Fig. 2. RMS on-state current as a function of surge duration; maximum values



 α = conduction angle

a = form factor = $I_{T(RMS)}/I_{T(AV)}$

Fig. 3. Total power dissipation as a function of RMS on-state current; maximum values

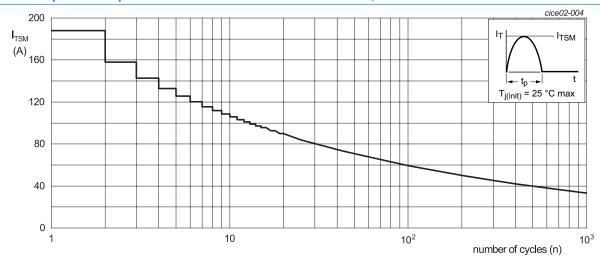
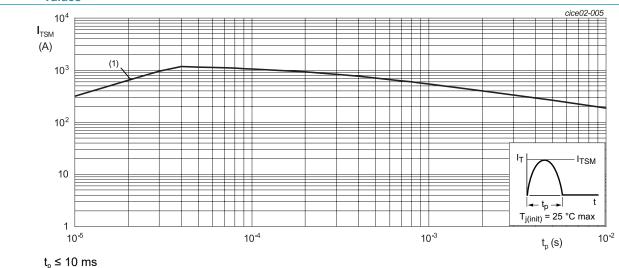


Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



(1) dl_⊤/dt limit

f = 50 Hz

Fig. 5. Non-repetitive peak on-state current as a function of pulse duration; maximum values

9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|---|-------------|-----|-----|-----|------|
| R _{th(j-mb)} | thermal resistance from junction to mounting base | Fig. 6 | - | - | 1 | K/W |
| $R_{\text{th(j-a)}}$ | thermal resistance from junction to ambient | in free air | - | 60 | - | K/W |

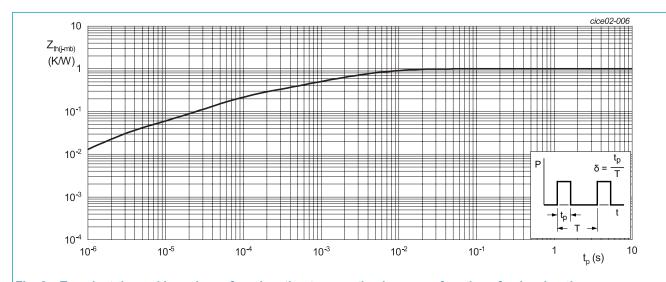


Fig. 6. Transient thermal impedance from junction to mounting base as a function of pulse duration

10. Characteristics

Table 7. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------------------|-----------------------------------|--|------|------|-----|------|
| Static cha | racteristics | | | | | |
| I _{GT} | gate trigger current | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C}; Fig. 7$ | 5 | - | 10 | mA |
| IL | latching current | $V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; T_j = 25 \text{ °C}; Fig. 8$ | - | - | 60 | mA |
| I _H | holding current | V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u> | - | - | 40 | mA |
| V _T | on-state voltage | I _T = 16 A; T _j = 25 °C; <u>Fig. 10</u> | - | - | 1.6 | V |
| V _{GT} | gate trigger voltage | V _D = 12 V; I _T = 0.1 A; T _j = 25 °C; <u>Fig. 11</u> | - | 8.0 | 1 | V |
| | | V _D = 400 V; I _T = 0.1 A; T _j = 125 °C | 0.25 | 0.45 | - | V |
| V_{GR} | gate reverse voltage | I _{RG} = 100 mA | 10 | - | - | V |
| I _D | off-state current | V _D = 600 V; T _j = 25 °C | - | - | 10 | μA |
| | | V _D = 600 V; T _j = 150 °C | - | - | 2 | mA |
| I _R | reverse current | V _D = 600 V; T _j = 25 °C | - | - | 10 | μA |
| | | V _D = 600 V; T _j = 150 °C | - | - | 2 | mA |
| Dynamic | characteristics | | | | | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 402 V; T_j = 150 °C; (V_{DM} = 67% of V_{DRM}); exponential waveform; gate open circuit | 400 | - | - | V/µs |
| \mathbf{t}_{gt} | gate-controlled turn-on time | $I_{TM} = 16 \text{ A}; V_D = 600 \text{ V}; I_G = 20 \text{ mA};$ $dI_G/dt = 5 \text{ A}/\mu\text{s}; T_j = 25 ^{\circ}\text{C}$ | - | 2 | - | μs |
| t _q | commutated turn-off time | I_{TM} = 2 A; t_p = 50 µs; dV/dt = 5 V/µs; dI/dt = 30 A/µs | - | - | 12 | μs |

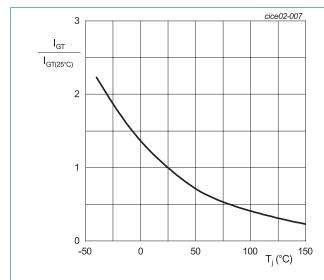


Fig. 7. Normalized gate trigger current as a function of junction temperature

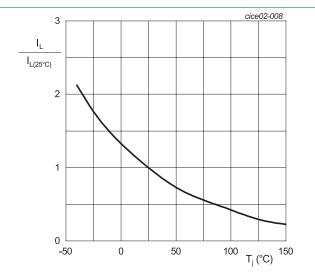


Fig. 8. Normalized latching current as a function of junction temperature

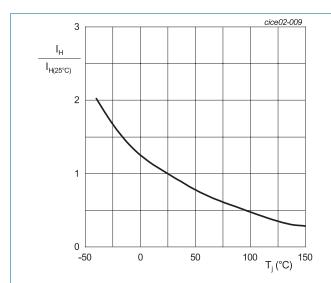
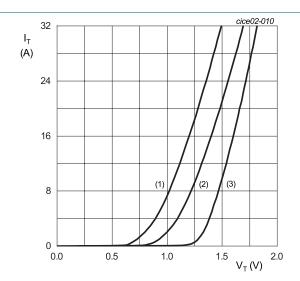


Fig. 9. Normalized holding current as a function of junction temperature



 $\begin{array}{l} V_o = 1.075 \text{ V; } R_s = 0.0196 \ \Omega \\ \text{(1) } T_j = 150 \ ^{\circ}\text{C; typical values} \\ \text{(2) } T_j = 150 \ ^{\circ}\text{C; maximum values} \\ \text{(3) } T_j = 25 \ ^{\circ}\text{C; maximum values} \end{array}$

Fig. 10. On-state current as a function of on-state voltage

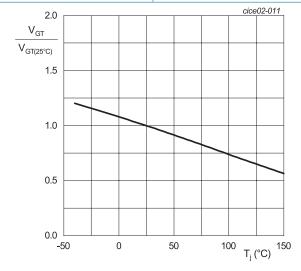
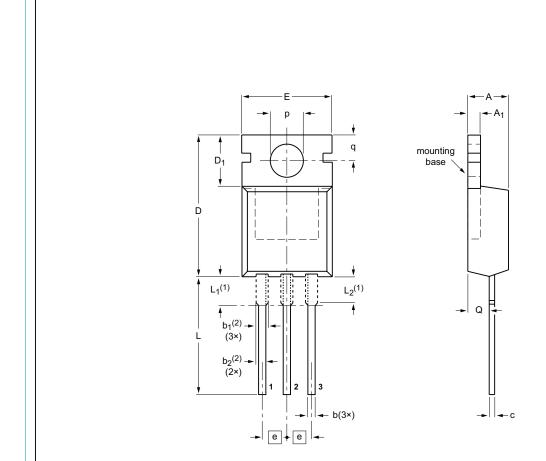


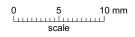
Fig. 11. Normalized gate trigger voltage as a function of junction temperature

SOT78

11. Package outline



Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB



DIMENSIONS (mm are the original dimensions)

| UNIT | Α | A ₁ | b | b ₁ ⁽²⁾ | b ₂ ⁽²⁾ | С | D | D ₁ | E | е | L | L ₁ ⁽¹⁾ | L ₂ ⁽¹⁾ max. | р | q | Q |
|------|------------|----------------|------------|-------------------------------|-------------------------------|------------|--------------|----------------|-------------|------|--------------|-------------------------------|---------------------------------------|------------|------------|------------|
| mm | 4.7 4.1 | 1.40 1.25 | 0.9 0.6 | 1.6 1.0 | 1.3 1.0 | 0.7 0.4 | 16.0 15.2 | 6.6 5.9 | 10.3 9.7 | 2.54 | 15.0 12.8 | 3.30 2.79 | 3.0 | 3.8 3.5 | 3.0 2.7 | 2.6 2.2 |

- Lead shoulder designs may vary.
 Dimension includes excess dambar.

| OUTLINE | | REFER | ENCES | EUROPEAN | ISSUE DATE |
|---------|-----|-----------------|-------|------------|---------------------------------|
| VERSION | IEC | JEDEC | JEITA | PROJECTION | ISSUE DATE |
| SOT78 | | 3-lead TO-220AB | SC-46 | | 08-04-23 08-06-13 |

12. Legal information

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| Document status [1][2] | Product status [3] | Definition |
|--------------------------------------|--------------------|---|
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For more information, please visit: http://www.ween-semi.com For sales office addresses, please send an email to: salesaddresses@ween-semi.com Date of release: 07 February 2022

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